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Attorney Docket No. 0180.0036

1FW 2818

**Appl. No.** 10/521,714 **Filed:** January 19, 2005

**Title:** Superlattice Nanopatterning of Wires and Complex Patterns

Applicant: Heath, et al. Group Art Unit: n/a Examiner: n/a

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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## Information Disclosure Statement

Sir:

In recognition of the continuing duty to disclose all relevant and material information of which they are aware, applicants direct the Examiner's attention to the attached PTO Form SB/08A. Copies of all non - US Patent citations are enclosed.

Dated: August 10, 2005

Respectfully submitted,

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PTO/SB/08A (08-03)

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Substitute for form 1449A/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet

Complete if Known				
Application Number	10/521,714			
Filing Date	January 19, 2005			
First Named Inventor	James R. Heath			
Art Unit	n/a			
Examiner Name	n/a			
Attorney Docket Number	0180.0036			

	U.S. PATENT DOCUMENTS					
Examiner Cite Initials* No.1		Document Number  Number - Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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	FOREIGN PATENT DOCUMENTS							
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Substitute for form 1449A/PTO Complete if Known 10/521,714 **Application Number** INFORMATION DISCLOSURE January 19, 2005 Filing Date STATEMENT BY APPLICANT James R. Heath First Named Inventor (use as many sheets as necessary) **Art Unit** n/a **Examiner Name** Sheet 2 of 3 **Attorney Docket Number** 0180.0036

		OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
	1	Battiston, F.M., J.P. Ramseyer, et al. (2001). "Chemical sensor based on a microfabricated cantilever array with simultaneous resonance-frequency and bending readout" Sensors and Actuators B-Chemical 77(1-2): 122-131.	
	2	Cleland, A.N. and M.L. Roukes (1996). "Fabrication of High Frequency Nanometer Scale Mechanical Resonators from Bulk Si Crystals." Applied Physics Letters 69(18): 2653-2655.	
	3	Collier, C.P., J.O. Jeppesen, et al. (2001). "Molecular-based electronically switchable tunnel junction devices." Journal of the American Chemical Society 123(50): 12632-12641.	
	4	Cui, Y., Q.Q. Wei, et al. (2001). "Nanowire nanosensors for highly sensitive and selective detection of biological and chemical species." Science 293(5533): 1289-1292.	
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Substitute for form 1449A/PTO			PTO	Complete if Known		
				Application Number	10/521,714	
INFORMA	ATION D	ISCLO	SURE	Filing Date	January 19, 2005	
STATEMENT BY APPLICANT (use as many sheets as necessary)			CANT	First Named Inventor	James R. Heath	
			essary)	Art Unit	n/a	
				Examiner Name	n/a	
Sheet	3	of	3	Attorney Docket Number	0180.0036	

OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T²		
	11	Chou, Stephen Y., et al. (1996). "Imprint Lithography With 25-Nanometer Resolution" Science, Vol. 272, pp. 85-87, 5 April 1996.			
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